

EMC TEST REPORT for Intentional Radiator No. SH10101109-001

Applicant : Hansong(Nanjing) Technology Ltd.

8th Kangping Road, Jiangning Economy and Technology

Development Zone, Nanjing, China, 211100

Manufacturer : Hansong(Nanjing) Technology Ltd.

8th Kangping Road, Jiangning Economy and Technology

Development Zone, Nanjing, China, 211100

Equipment : MusicLites

Type/Model : ML-1

SUMMARY

The equipment complies with the requirements according to the following standard(s):

47CFR Part 15 (2009): Radio Frequency Devices

ANSIC63.4 (2003): American National Standard for Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the Range of 9 kHz to 40 GHz

RSS-210 Issue 8 (December 2010): Low-power Licence-exempt Radiocommunication Devices (All Frequency Bands): Category I Equipment

RSS-Gen Issue 3 (December 2010): General Requirements and Information for the Certification of Radiocommunication Equipment

RSS-310 Issue 3 (December 2010): Licence-exempt Radio Apparatus (All Frequency Bands): Category II Equipment

Date of issue: May 10, 2011

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1. General Information

1.1 Applicant Information

Applicant: Hansong(Nanjing) Technology Ltd.

8th Kangping Road, Jiangning Economy and Technology Development Zone, Nanjing, China,

211100

Name of contact: Una Chi

Tel: 86 25 66612193 Fax: 86 25 66612091

Manufacturer: Hansong(Nanjing) Technology Ltd.

8th Kangping Road, Jiangning Economy and Technology Development Zone, Nanjing, China,

211100

Sample received date : Oct 29, 2010

Date of test : Oct 29, 2010 ~ Dec 20, 2010

1.2 Identification of the EUT

Equipment: MusicLites

Type/model: ML-1

FCC ID: XCO-OAML1

IC: 7756A- OAML1



1.3 Technical specification

Operation Frequency Band: 2412 - 2464 MHz

Modulation: QPSK

Antenna Designation: Integral, PCB antenna

Gain of Antenna: 1.0dBi max used.

Rating: AC 100 – 120V, 60Hz, 0.5A, 30W

Description of EUT: Here is one model only.

The EUT is a music light.

There are two antennas among the RF module of the EUT, namely chain 1 and chain 2. The two antennas

cannot transmit simultaneously.

I/O port: None

Channel Description:

Channel	Frequency
Identifier	(MHz)
low	2412
middle	2438
high	2464

1.4 Mode of operation during the test / Test peripherals used

Within this test report, both transmitter and receiver mode of EUT were tested.

While testing transmitter mode of EUT, the EUT was set as continuous transmitting mode with internal modulation.

While testing receiver mode of EUT, the corresponding transmitter connected with an iPod (model: A1199) generating audio signal in close proximity to the EUT was employed. For the EUT is hanged in the ceiling, it was set up as its normal use while testing.



2. Test Specification

2.1 Instrument list

2.1 Instrument list	·		Ī	T	Т
Equipment	Type	Manu.	Internal no.	Cal. Date	Due date
Test Receiver	ESIB 26	R&S	EC 3045	2010-6-1	2011-5-31
Semi-anechoic	-	Albatross	EC 3048	2010-6-1	2011-5-31
chamber		project			
A.M.N.	ESH2-Z5	R&S	EC 3119	2010-1-23	2011-1-22
Test Receiver	ESCS 30	R&S	EC 2107	2010-1-23	2011-1-22
Ultra-broadband	CBL 6112D	TESEQ	EC 4206	2010-5-30	2011-6-1
Antenna					
Horn Antenna	HF 906	R&S	EC 3049	2010-6-30	2011-6-29
Pre-amplifier	Pre-amp 18	R&S	EC 3222	2010-6-30	2011-6-29
Signal generator	SMR 20	R&S	EC 3044-1	2010-8-21	2011-8-20
High Pass Filter	WHKX	Wainwrig	EC4297-1	2010-2-8	2011-2-7
	1.0/15G-	ht			
	10SS				
High Pass Filter	WHKX	Wainwrig	EC4297-2	2010-2-8	2011-2-7
	2.8/18G-	ht			
	12SS				
High Pass Filter	WHKX	Wainwrig	EC4297-3	2010-2-8	2011-2-7
	7.0/1.8G-8SS	ht			
Band Reject Filter	WRCGV	Wainwrig	EC4297-4	2010-2-8	2011-2-7
	2400/2483-	ht			
	2390/2493-				
	35/10SS				
Spectrum	E4408B	Agilent	MY45102679	2010-11-20	2011-11-19
Analyzer					
Spectrum	E4446A	Agilent	MY45300103	2010-6-11	2011-6-10
Analyzer					
EMI Test	ESCI	R&S	100573	2010-5-23	2011-5-22
Receiver					
Preamplifier	AP-025C	Quietek	QT-AP003	2010-11-25	2011-11-24
Preamplifier	AP-180C	Quietek	CHM-	2010-11-25	2011-11-24
			0602013		
Broad-Band Horn	BBHA9120D	Schwarzb	496	2010-11-25	2011-11-24
Antenna		eck			
Broad-Band Horn	BBHA9170	Schwarzb	294	2010-11-25	2011-11-24
Antenna		eck			

2.2 Test Standard

47CFR Part 15 (2009)

ANSI C63.4: 2003

RSS-210 Issue 8 (December 2010)

RSS-Gen Issue 3 (December 2010)

RSS-310 Issue 3 (December 2010)



2.3 Test Summary

This report applies to tested sample only. This report shall not be reproduced in part without written approval of Intertek Testing Service Shanghai Limited.

TEST ITEM	FCC REFERANCE	IC REFERANCE	RESULT
Minimum 6dB Bandwidth	15.247(a)(2)	RSS-210 Issue 8	Pass
		Annex 8	
Maximum peak output power	15.247(b)	RSS-210 Issue 8	Pass
		Annex 8	
Power spectrum density	15.247(e)	RSS-210 Issue 8	Pass
		Annex 8	
Radiated emission	15.205 & 15.209	RSS-210 Issue 8	Pass
		Clause 2	
Emission outside the	15.247(d)	RSS-210 Issue 8	Pass
frequency band		Annex 8	
Power line conducted emission	15.207	RSS-Gen Issue 3	Pass
		Clause 7.2.4	
Channel number of hopping	15.247(a)(1)(iii)	RSS-210 Issue 8	NA
system		Annex 8	
Average time of occupancy in	15.247(a)(1)(iii)	RSS-210 Issue 8	NA
any channel		Annex 8	
Occupied bandwidth	-	RSS-Gen Issue 3	Tested
		Clause 4.6.1	
Spurious emission for receiver	-	RSS-310 Issue 3	Pass
		Clause 3.1	

2.4 Data rate VS power

The data rate of EUT is fixed and cannot by adjusted.



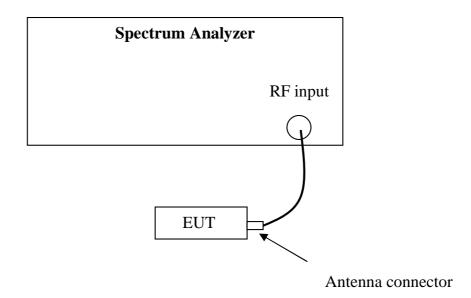
3. Minimum 6dB Bandwidth

Test result: PASS

3.1 Limit

For systems using digital modulation techniques that may operate in the 902 - 928 MHz, 2400 - 2483.5 MHz and 5725 - 5850 MHz bands, the minimum 6 dB bandwidth shall be at least 500 kHz.

3.2 Test Configuration



3.3 Test Procedure and test setup

The minimum 6dB bandwidth per FCC §15.247(a)(2) is measured using the Spectrum Analyzer with the resolutions bandwidth set at 100kHz, the video bandwidth set at 300kHz, and the SPAN>>RBW. The test was performed at 3 channels (lowest, middle and highest channel).

The EUT was tested according to DTS test procedure of Oct 2002 KDB558074 for compliance to FCC 47CFR 15.247 requirements.



3.4 Test Protocol

Temperature : 22°C Relative Humidity : 43 %

Mode	СН	Chain 1	Chain 2	Limit
Mode		(MHz)	(MHz)	(MHz)
	L	9.62	9.79	≥0.5
-	M	9.77	9.79	≥0.5
	Н	9.77	9.79	≥0.5



4. Maximum peak output power

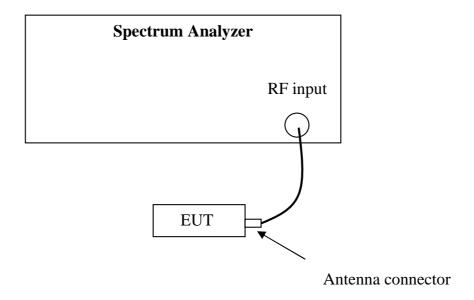
Test result: Pass

4.1 Test limit

For frequency hopping systems operating in the 2400-2483.5 MHz band employing at least 75 non-overlapping hopping channels, and all frequency hopping systems in the 5725-5850 MHz band: 1 watt

For all other frequency hopping systems in the 2400-2483.5 MHz band: 0.125 watts If the transmitting antenna of directional gain greater than 6dBi is used, the power shall be reduced by the amount in dB that the directional gain of the antenna exceeds 6dBi. For systems using digital modulation in the 902-928 MHz, 2400-2483.5 MHz, and 5725-5850 MHz bands: 1 Watt.

4.2 Test Configuration



4.3 Test procedure and test setup

The power output per FCC § 15.247(b) is measured using the Spectrum Analyzer with the resolutions bandwidth set at 1MHz, the video bandwidth set at 3MHz, and the SPAN>>RBW. The test was performed at 3 channels (lowest, middle and highest channel). The EUT was tested according to DTS test procedure of Oct 2002 KDB558074 for compliance to FCC 47CFR 15.247 requirements (Power Output Option 2, method#1).



4.4 Test protocol

Temperature : 22 °C Relative Humidity : 43 %

Chain	СН	Cable loss (dB)	Corrected reading (dBm)	Limit (dBm)
	L	0.90	11.12	≤30
1	M	0.90	10.10	≤30
	Н	0.90	10.14	≤30
	L	0.90	10.71	≤30
2	M	0.90	10.49	≤30
	Н	0.90	10.81	≤30

Note: Please refer to the test data for corrected reading.

For the gain of antenna = 1.0dBi, the maximum e.i.r.p = 11.12dBm + 1.00dBi = 12.12dBm = 16.29mW (lower than the e.i.r.p limit of 4W showed in RSS-210.).



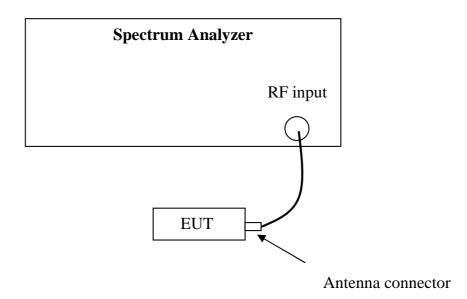
5. Power spectrum density

Test result: Pass

5.1 Test limit

For digitally modulated systems, the power spectral density conducted from the intentional radiator to the antenna shall not be greater than 8dBm in any 3 kHz band during any time interval of continuous transmission.

5.2 Test Configuration



5.3 Test procedure and test setup

The power output per FCC §15.247(e) was measured using the Spectrum Analyzer with the resolutions bandwidth set at 3kHz, the video bandwidth set at 10kHz. The test was performed at 3 channels (lowest, middle and highest channel).

The EUT was tested according to DTS test procedure of Oct 2002 KDB558074 for compliance to FCC 47CFR 15.247 requirements.



5.4 Test Protocol

Temperature : 22 °C Relative Humidity : 43 %

Mode	СН	Chain 1 (dBm/3kHz)	Chain 2 (dBm/3kHz)	Limit (dBm/3kHz)
	L	-17.08	-16.39	≤8
-	M	-16.80	-16.62	≤8
	Н	-17.36	-16.22	≤8



6. Radiated emission

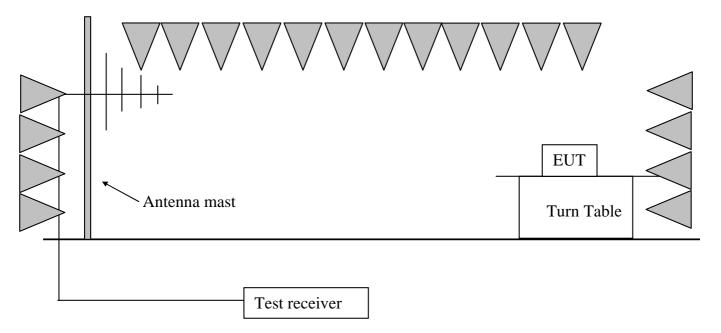
Test result: PASS

6.1 Test limit

The radiated emissions which fall in the restricted bands, as defined in §15.205(a), must also comply with the radiated emission limits specified in §15.209(a) showed as below:

Frequency (MHz)	Field Strength (dBuV/m)	Measurement Distance (m)
30 - 88	40.0	3
88 - 216	43.5	3
216 - 960	46.0	3
Above 960	54.0	3

6.2 Test Configuration





6.3 Test procedure and test setup

The measurement was applied in a semi-anechoic chamber. While testing for spurious emission higher than 1GHz, if applied, the pre-amplifier would be equipped just at the output terminal of the antenna.

The EUT and simulators were placed on a 0.8m high wooden turntable above the horizontal metal ground plane. The turn table rotated 360 degrees to determine the position of the maximum emission level. The EUT was set 3 meters away from the receiving antenna which was mounted on an antenna mast. The antenna moved up and down between from 1meter to 4 meters to find out the maximum emission level.

The EUT was tested according to DTS test procedure of Oct 2002 KDB558074 for compliance to FCC 47CFR 15.247 requirements.

The radiated emission was measured using the Spectrum Analyzer with the resolutions bandwidth set as:

RBW = 100kHz, VBW = 300kHz (30MHz~1GHz) RBW = 1MHz, VBW = 3MHz (>1GHz for PK); RBW = 1MHz, VBW = 10Hz (>1GHz for AV);



6.4 Test protocol

The test is performed while chain 1 is active which has higher conducted output power:

СН	Antenna	Frequency (MHz)	Correct Factor (dB/m)	Corrected Reading (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector
	V	2411.05	30.70	93.20	Fundamental	/	PK
	V	41.66	11.90	38.20	Spurious	/	QP
	V	43.60	10.90	38.40	Spurious	/	QP
	V	53.33	7.10	35.60	Spurious	/	QP
L	V	70.82	6.40	36.00	Spurious	/	QP
L	Н	123.31	13.10	40.80	43.50	2.70	PK
	Н	166.07	10.90	38.10	43.50	5.40	PK
	Н	2390.00	30.70	52.30	54.00	1.70	PK
	Н	2483.50	30.70	46.80	54.00	7.20	PK
	Н	4823.67	-2.80	38.30	54.00	15.70	PK
	V	2440.36	30.70	92.40	Fundamental	/	PK
	V	41.66	11.90	38.20	Spurious	/	QP
	V	43.60	10.90	38.40	Spurious	/	QP
	V	53.33	7.10	35.60	Spurious	/	QP
M	V	70.82	6.40	36.00	Spurious	/	QP
IVI	Н	123.31	13.10	40.80	43.50	2.70	PK
	Н	166.07	10.90	38.10	43.50	5.40	PK
	Н	2390.00	30.70	46.10	54.00	7.90	PK
	Н	2483.50	30.70	46.50	54.00	7.50	PK
	V	4881.30	-2.80	38.60	54.00	15.40	PK
Н	V	2465.81	30.70	92.60	Fundamental	/	PK
	V	41.66	11.90	38.20	Spurious	/	QP
	V	43.60	10.90	38.40	Spurious	/	QP
	V	53.33	7.10	35.60	Spurious	/	QP
	V	70.82	6.40	36.00	Spurious	/	QP
	Н	123.31	13.10	40.80	43.50	2.70	PK



Н	166.07	10.90	38.10	43.50	5.40	PK
Н	2390.00	30.70	46.30	54.00	7.70	PK
Н	2483.50	30.70	53.00	54.00	1.00	PK
V	4931.17	-2.80	38.10	54.00	15.90	PK

Remark: 1. For fundamental & restrict emission at 2300-2390MHz and 2483.5-2500MHz test, no amplifier is employed.

- 2. Correct Factor = Antenna Factor + Cable Loss (-Amplifier, is employed)
- 3. Corrected Reading = Original Receiver Reading + Correct Factor
- 4. Margin = limit Corrected Reading
- 5. If the PK reading is lower than AV limit, the AV test can be elided.

Example: Assuming Antenna Factor = 30.20dB/m, Cable Loss = 2.00dB,

Gain of Preamplifier = 32.00dB, Original Receiver Reading = 10dBuV.

Then Correct Factor = 30.20 + 2.00 - 32.00 = 0.20dB/m; Corrected Reading =

10dBuV + 0.20dB/m = 10.20dBuV/m

Assuming limit = 54dBuV/m, Corrected Reading = 10.20dBuV/m, then Margin = 54 - 10.20 = 43.80dBuV/m



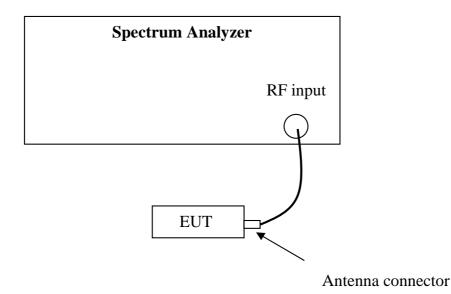
7. Emission outside the frequency Band

Test result: PASS

7.1 Limit

In any 100 kHz bandwidth outside the frequency band in which the spread spectrum intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power.

7.2 Test Configuration



7.3 Test procedure and test setup

The Emission outside the frequency Band per FCC §15.247(d) is measured using the Spectrum Analyzer with the resolutions bandwidth set at 100kHz, the video bandwidth set at 300kHz, and the SPAN>>RBW.

The EUT was tested according to DTS test procedure of Oct 2002 KDB558074 for compliance to FCC 47CFR 15.247 requirements.



7.4 Test protocol

It was found all the emission outside the frequency band is at least $20~\mathrm{dB}$ below that in the $100~\mathrm{kHz}$ bandwidth within the band.

Chain	СН	Max reading among band (dBm)	Min Attenuation outside band (dB)	Limit (dB)
	L	-6.68	33.89	
1	M	-7.02	39.52	
	Н	-7.89	38.36	> 20
	L	-6.42	34.47	>20
2	M	-6.35	38.36	
	Н	-6.19	39.63	

Note: Min Attenuation outside band = Max reading among band – Max reading outside band. Please refer to the test data for the edge band.



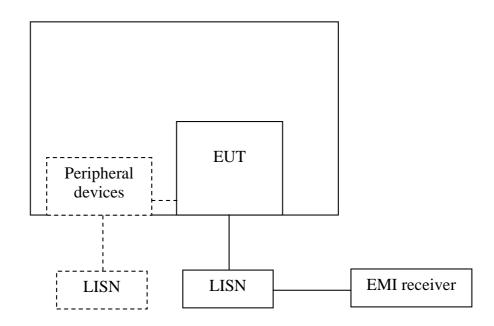
8. Power line conducted emission

Test result: Pass

8.1 Limit

Frequency of Emission (MHz)	Conducted Limit (dBuV)				
	QP	AV			
0.15-0.5	66 to 56*	56 to 46 *			
0.5-5	56	46			
5-30	60	50			
* Decreases with the logarithm of the frequency.					

8.2 Test configuration



For table top equipment, wooden support is 0.8m height table

For floor standing equipment, wooden support is 0.1m height rack.



8.3 Test procedure and test set up

The EUT are connected to the main power through a line impedance stabilization network (LISN). This provides a $50\Omega/50uH$ coupling impedance for the measuring equipment. The peripheral devices are also connected to the main power through a LISN that provides a $50\Omega/50uH$ coupling impedance with 50Ω termination.

Both sides (Line and Neutral) of AC line are checked for maximum conducted interference. In order to find the maximum emission, the relative positions of equipment and all of the interface cables must be changed according to ANSI C63.4 on conducted measurement. The bandwidth of the test receiver is set at 9 kHz.

The EUT was tested according to DTS test procedure of Oct 2002 KDB558074 for compliance to FCC 47CFR 15.247 requirements.

8.4 Test protocol

Frequency	Correct Factor	Corrected Reading		Limit		Margin	
	(dB)	(dBuV)		(dBuV)		(dB)	
		QP	AV	QP	AV	QP	AV
0.26 (L)	3.00	54.66	41.53	61.56	51.56	6.90	10.03
0.38 (L)	3.00	45.41	33.17	58.21	48.21	12.80	15.04
0.51 (N)	3.00	36.74	29.48	56.00	46.00	18.26	16.52
0.64 (L)	3.00	34.78	30.07	56.00	46.00	21.22	15.93
0.77 (L)	3.00	27.68	23.36	56.00	46.00	28.32	22.64
1.54 (N)	3.00	27.35	25.66	56.00	46.00	28.65	20.34

Remark: 1. Correction Factor (dB) = LISN Factor (dB) + Cable Loss (dB).

2. Margin (dB) = Limit - Corrected Reading.



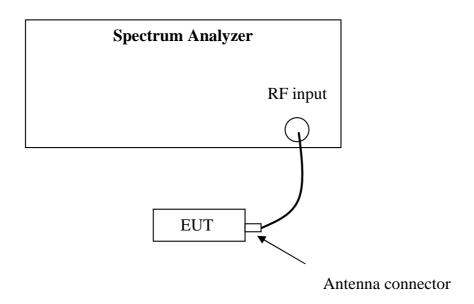
9. Channel Number of hopping system

Test result: NA

9.1 Limit

Frequency hopping systems in the 2400-2483.5 MHz band shall use at least 15 channels.

9.2 Test Configuration



9.3 Test procedure and test setup

The channel number per FCC §15.247(a)(1)(iii) is measured using the Spectrum Analyzer with the resolutions bandwidth set at 100kHz, the video bandwidth set at 300kHz, and the SPAN>>RBW.

The RF passband of the EUT was divided into 3 appropriate bands to test.



9.4 Test protocol

Channel Number	Limit
-	≥15



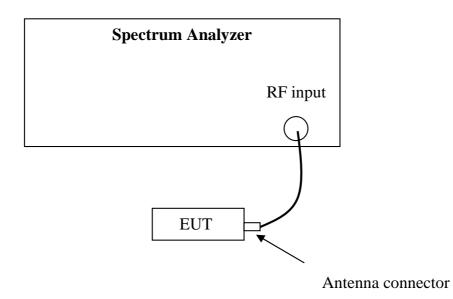
10. Average time of occupancy in any channel

Test result: NA

10.1 Limit

The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed. Frequency hopping systems may avoid or suppress transmissions on a particular hopping frequency provided that a minimum of 15 channels are used.

10.2 Test Configuration



10.3 Test procedure and test setup

Average time of occupancy in any channel per FCC § 15.247(a)(1)(iii) is measured using the Spectrum Analyzer with the resolutions bandwidth set at 100kHz, the video bandwidth set at 300kHz, and the SPAN set to be 0Hz to test in time domain. The test is performed at the middle channel.



10.4 Test protocol

Packet	Observed	Time of occupancy	Hops among the	Average time	Limit
	period	for single hopping	interval of 3.6 s	of occupancy	
	(s)	(ms)		(s)	(s)
	P	0	I	T	
Packet Type 4	-	-	-	-	≤0.4
Packet Type 11	-	-	-	-	≤0.4
Packet Type 15	-	-	-	-	≤0.4

Remark: 1. There are 79 channels in all. So the observed period P = 0.4 * 79 = 31.6 s.2. Average time of occupancy T = O *I * P / 3.6



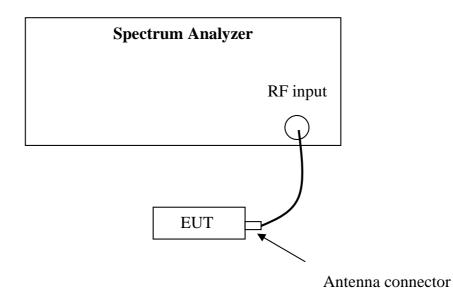
11. Occupied Bandwidth

Test Status: Tested

11.1 Test limit

None

11.2 Test Configuration



11.3 Test procedure and test setup

The occupied bandwidth per RSS-Gen Issue 3 Clause 4.6.1 was measured using the Spectrum Analyzer with the resolutions bandwidth set at 1MHz, the video bandwidth set at 3MHz.



11.4 Test protocol

Temperature : 22 °C Relative Humidity : 43 %

Occupied Bandwidth (MHz)				
15.43				



12. Spurious emission for receiver

Test result: PASS

12.1 Test limit

The spurious emission shall test through 3 times tuneable or local oscillator frequency whichever is the higher, without exceeding 40 GHz.

- 1) If a conducted measurement is made, no spurious output signals appearing at the antenna terminals shall exceed 2nW per any 4 kHz spurious frequency in the band 30-1000 MHz, or 5nW above 1 GHz.
- 2) If a radiated measurement is made, all spurious emissions shall comply with the limits of Table below:

Frequency (MHz)	Field Strength (dBuV/m)	Measurement Distance (m)
30 - 88	40.0	3
88 - 216	43.5	3
216 - 960	46.0	3
Above 960	54.0	3

12.2 Test Configuration

Please refer to clause 6.2

12.3 Test procedure and test setup

Please refer to clause 6.3.



12.4 Test protocol

Polarization	Frequency (MHz)	Correct Factor (dB/m)	Corrected Reading (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector
V	41.66	12.30	34.20	40.00	5.80	QP
V	47.49	9.80	38.90	40.00	1.10	QP
V	51.38	9.00	36.90	40.00	3.10	PK
V	68.88	10.00	35.60	40.00	4.40	QP
V	72.77	10.20	34.70	40.00	5.30	PK
Н	99.98	11.40	28.70	43.50	14.80	PK
Н	117.47	11.30	28.90	43.50	14.60	PK
V	3100.20	-6.60	36.50	54.00	17.50	PK
V	3070.14	-6.70	36.40	54.00	17.60	PK

Remark: 1. Correct Factor = Antenna Factor + Cable Loss (-Amplifier, is employed)

- 2. Corrected Reading = Original Receiver Reading + Correct Factor
- 3. Margin = limit Corrected Reading

Example: Assuming Antenna Factor = 30.20dB/m, Cable Loss = 2.00dB,

Original Receiver Reading = 10dBuV.

Then Correct Factor = 30.20 + 2.00 = 32.20dB/m; Corrected Reading = 10dBuV + 32.20dB/m = 42.20dBuV/m

Assuming limit = 54 dBuV/m, Corrected Reading = 42.20 dBuV/m, then Margin = 54 - 42.20 = 11.80 dBuV/m